

Search Notes



Application/Control No.

10/635,916

Examiner

Hien X. Vo

Applicant(s)/Patent under
Reexamination

SWAINE ET AL.

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	176	4/15/2005	VXH
	177		
	178		
	187		
711	162		
	154		
717	124		
	128		
714	45		
UPDATE SEARCH			
		ABOVE	
		11/28/05	VXH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Plus search	3/9/2005	VXH
EAST	4/13/2005	